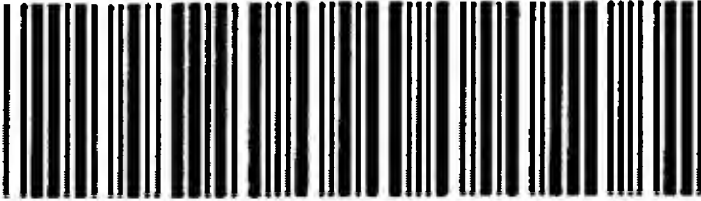


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/526,223	TANAKA ET AL.	
	Examiner	Art Unit	
	Louis K. Huynh	3721	

SEARCHED			
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53	403 472 139.5	5/18/2007	/LH/
206	521 522	5/18/2007	/LH/
383	3	5/18/2007	/LH/
Updated	All above	1/22/2008	LH

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR